

Search Notes



Application No.

10/724,682

Examiner

Jong-Suk (James) Lee

Applicant(s)

FAGAN ET AL.

Art Unit

3673

SEARCHED

Class	Subclass	Date	Examiner
405	128.25, 128.45 128.5 128.7	6/25/2004	JL
405	128.75	6/25/2004	JL
405	129.2	6/25/2004	JL
405	129.25	6/25/2004	JL
405	129.95 271	6/25/2004	JL
405	129.9 269	6/25/2004	JL
210	96.1 170	6/25/2004	JL
210	747 752	6/25/2004	JL
172	508 540	6/25/2004	JL
172	813 817	6/25/2004	JL
37	403,405	6/25/2004	JL
37	395,397	6/25/2004	JL
588	250-253	6/25/2004	JL
405 210 172 37, 588	Search updated	3/30/05	n

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor Name Search	6/25/2004	JL

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